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(12) United States Design Patent

Laverack et al.

(10) Patent No.:

US D675,336 S

(45) Date of Patent: ** Jan. 29, 2013

(54) TESTING APPARATUS

(75) Inventors: Paul Laverack, Milton Keynes (GB);

Richard Luxton, Leighton Buzzard (GB); Robin Brown, Cambs (GB)

(73) Assignee: SPD Swiss Precision Diagnostics

GmbH, Geneva (CH)

(**) Term: 14 Years

(21) Appl. No.: 29/389,578

(22) Filed: Apr. 13, 2011

(30) Foreign Application Priority Data

	et. 13, 2010 et. 13, 2010	` ′			
(51)	LOC (9) Cl				
` ′	U.S. Cl				
(58)	Field of Cla	ssification	n Search	D24/	216–217,
	D2	4/219, 222	2–226, 227,	231, 232,	107, 169,
	D_2	4/186; D	10/81; 422/	400–404,	408, 430,
	42	2/68.1, 69	, 500; 435/2	287.1, 287	.3, 287.4,
			435/288.1	1, 288.3, 2	88.7, 806
	See applicat	ion file for	r complete s	search histo	ory.

(56) References Cited

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D526,719	S	*	8/2006	Richie et al D24/186
D547,879			7/2007	Lee
D561,905	S	*	2/2008	Ramel et al D24/216
D607,347	S	*	1/2010	Goh et al
D648,029	S	*	11/2011	Presta et al D24/169

^{*} cited by examiner

Primary Examiner — Anhdao Doan

(74) Attorney, Agent, or Firm — Haynes and Boone, LLP

(57) CLAIM

The ornamental design for a testing apparatus, as shown and described.

DESCRIPTION

FIG. 1 is a perspective view of a testing apparatus showing our new design, the perspective view of FIG. 1 showing the testing apparatus in a closed configuration;

FIG. $\overline{2}$ is a front elevational view of the testing apparatus in the closed configuration;

FIG. 3 is a left side elevational view of the testing apparatus in the closed configuration;

FIG. 4 is a rear elevational view of the testing apparatus in the closed configuration;

FIG. 5 is a top plan view of the testing apparatus in the closed configuration;

FIG. 6 is a bottom plan view of the testing apparatus in the closed configuration;

FIG. 7 is another perspective view of the testing apparatus in the closed configuration, and further includes environmental structure illustrated in broken lines;

FIG. 8 is a perspective view showing the testing apparatus in an open configuration;

FIG. 9 is a front elevational view of the testing apparatus in the open configuration;

FIG. 10 is a left side elevational view of the testing apparatus in the open configuration;

FIG. 11 is a rear elevational view of the testing apparatus in the open configuration;

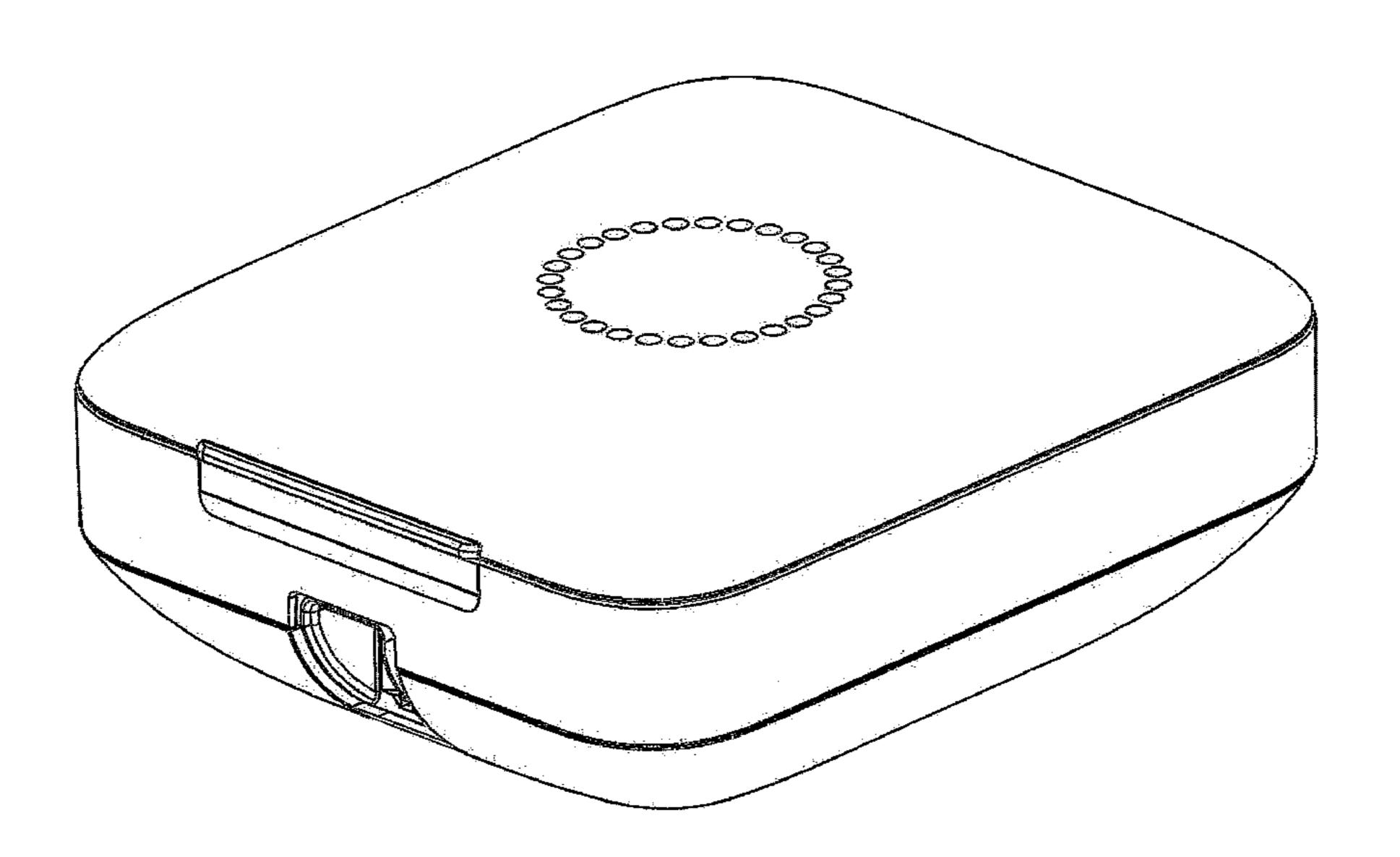
FIG. 12 is a top plan view of the testing apparatus in the open configuration;

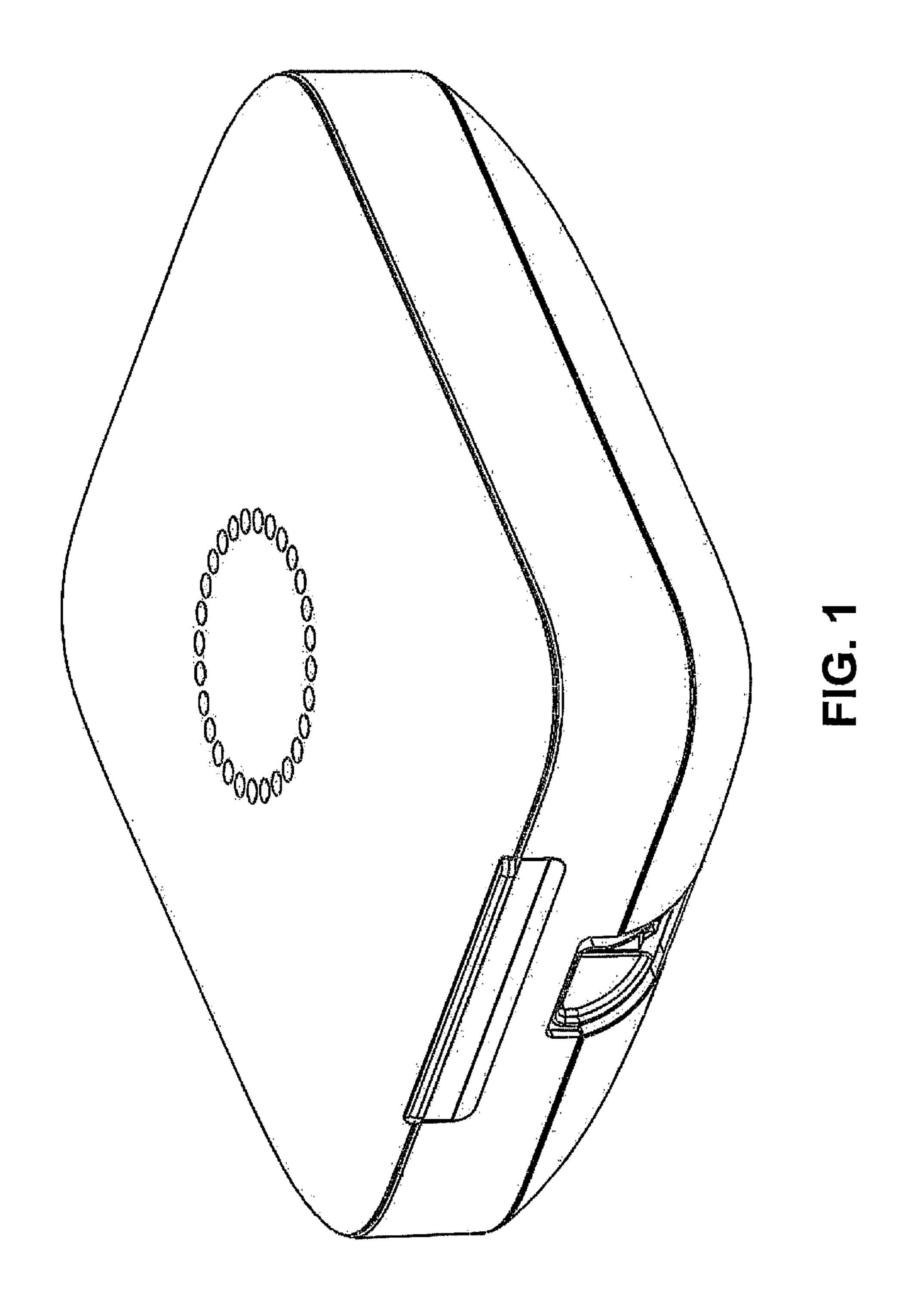
FIG. 13 is a bottom plan view of the testing apparatus in the open configuration; and,

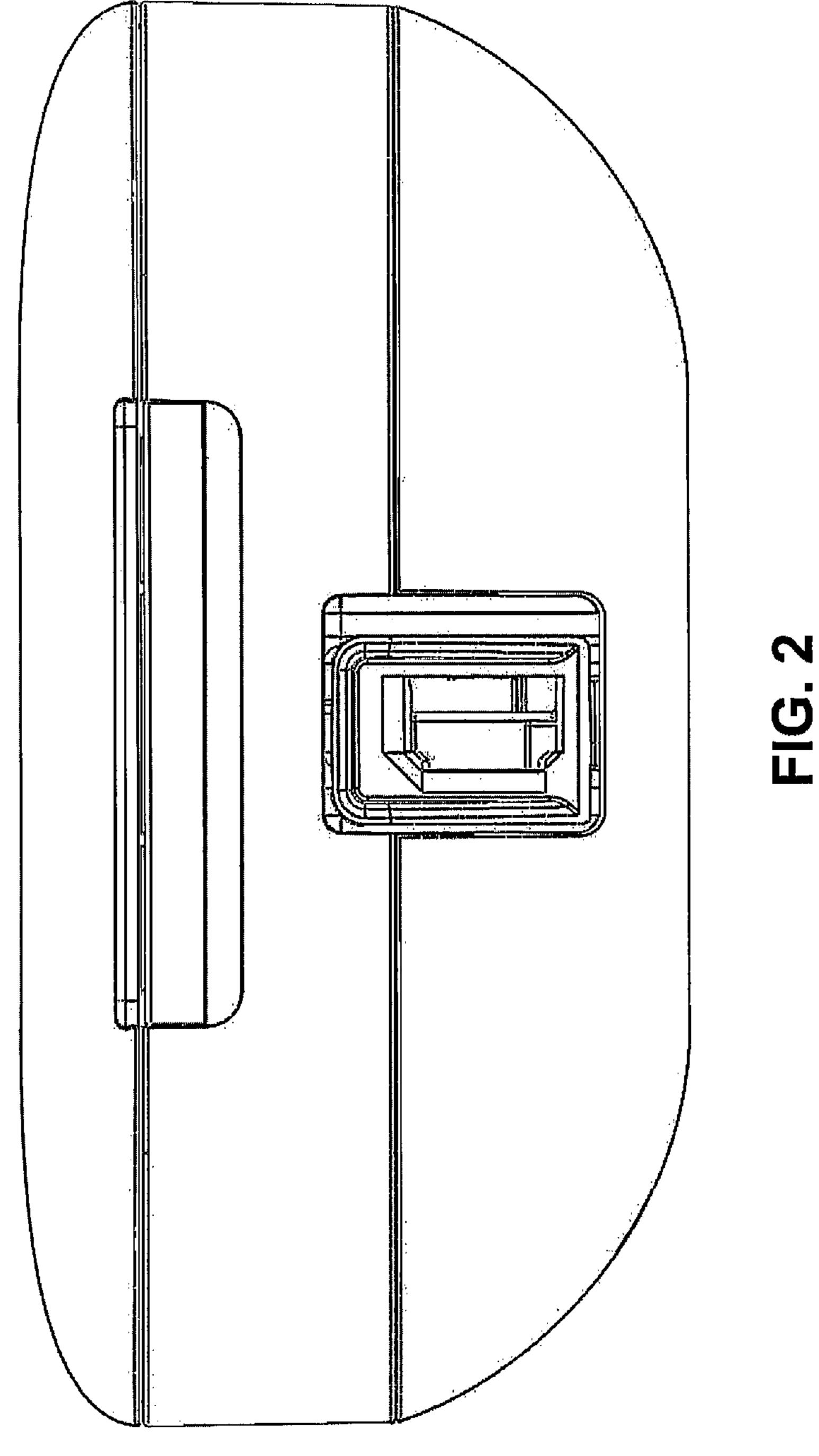
FIG. 14 is another perspective view of the testing apparatus in the open configuration, and further includes environmental structure illustrated in broken lines.

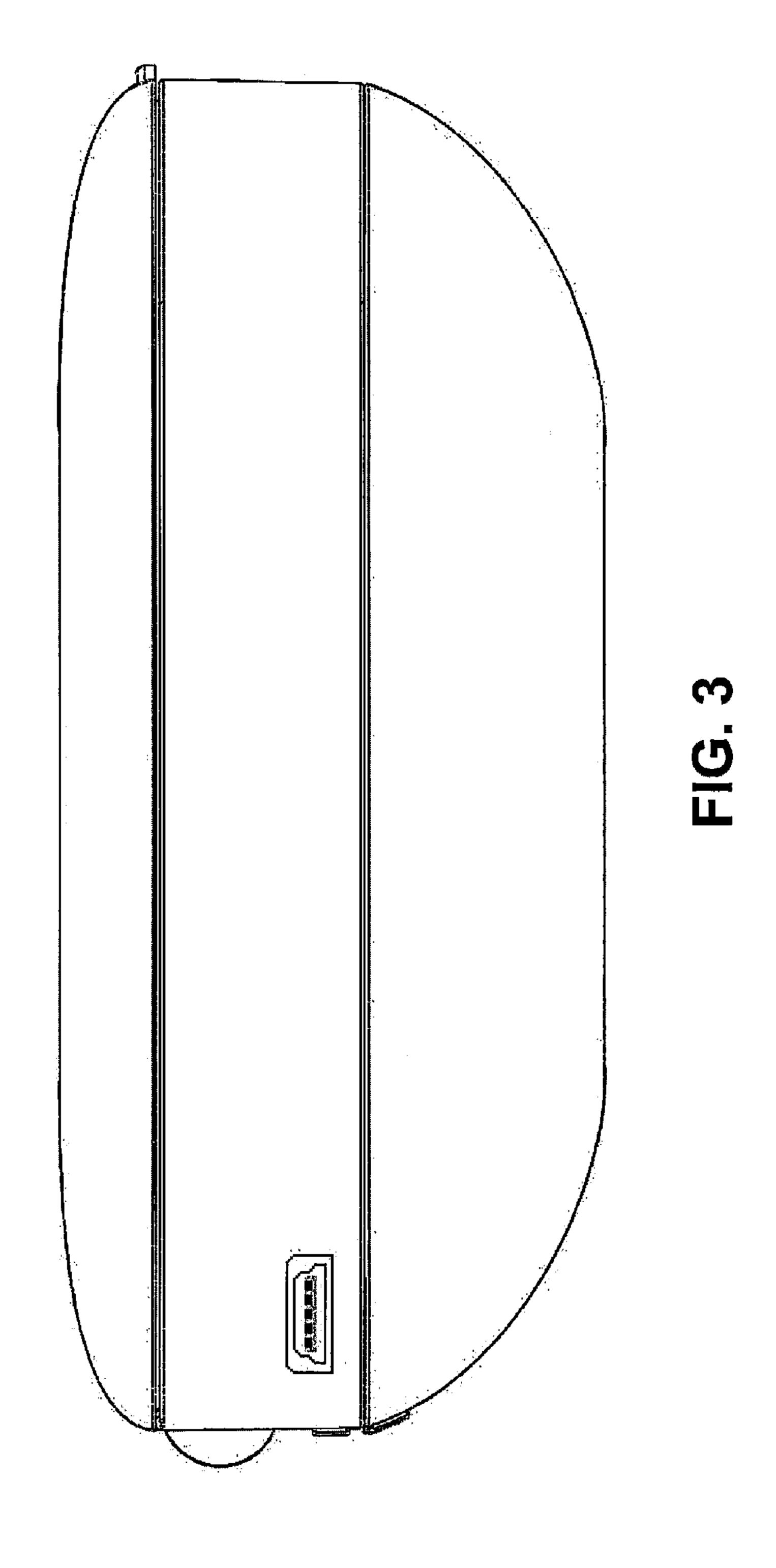
The broken lines in the drawing views are included for the purpose of illustrating portions of the testing apparatus that form no part of the claimed design.

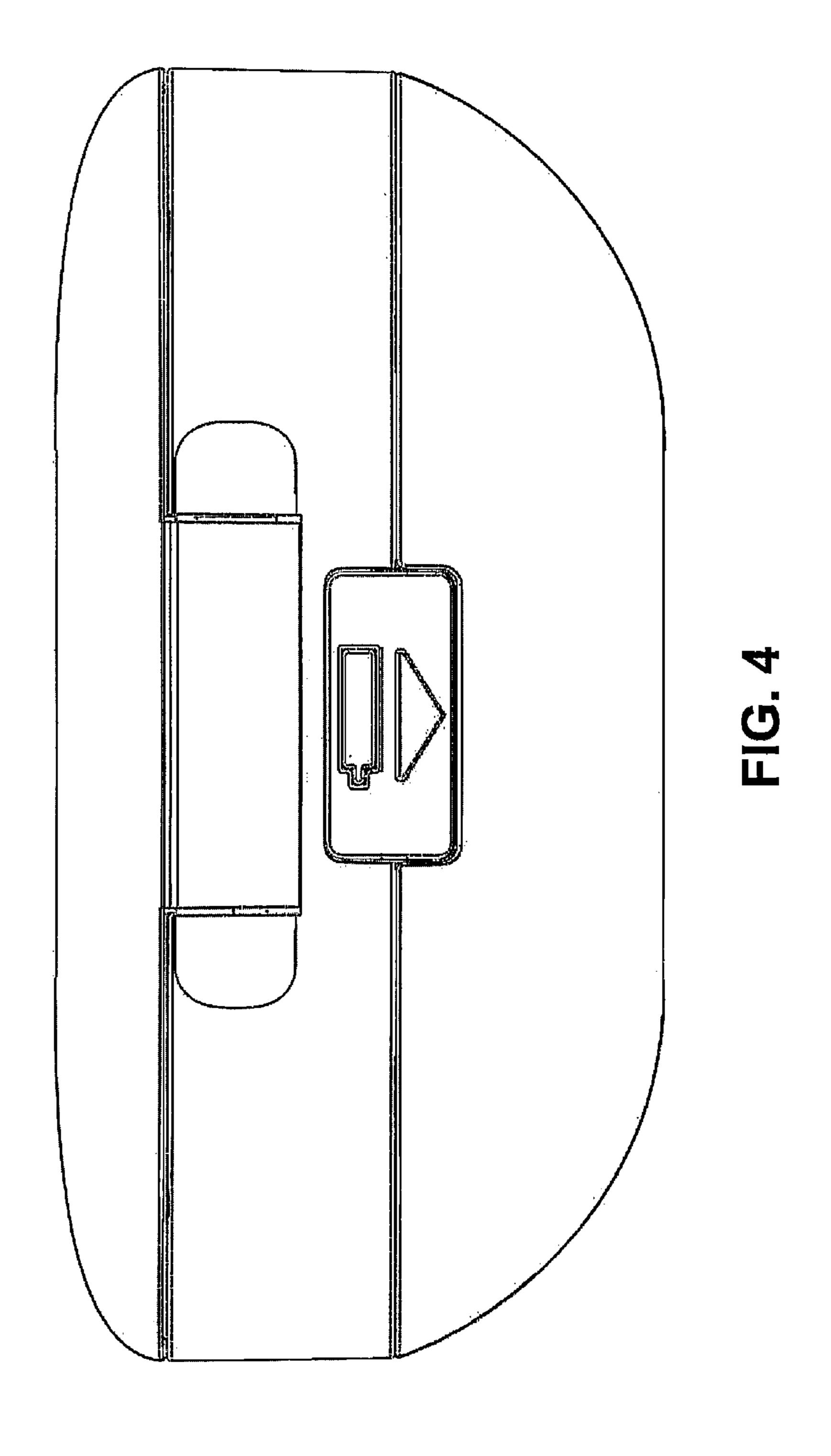
1 Claim, 14 Drawing Sheets











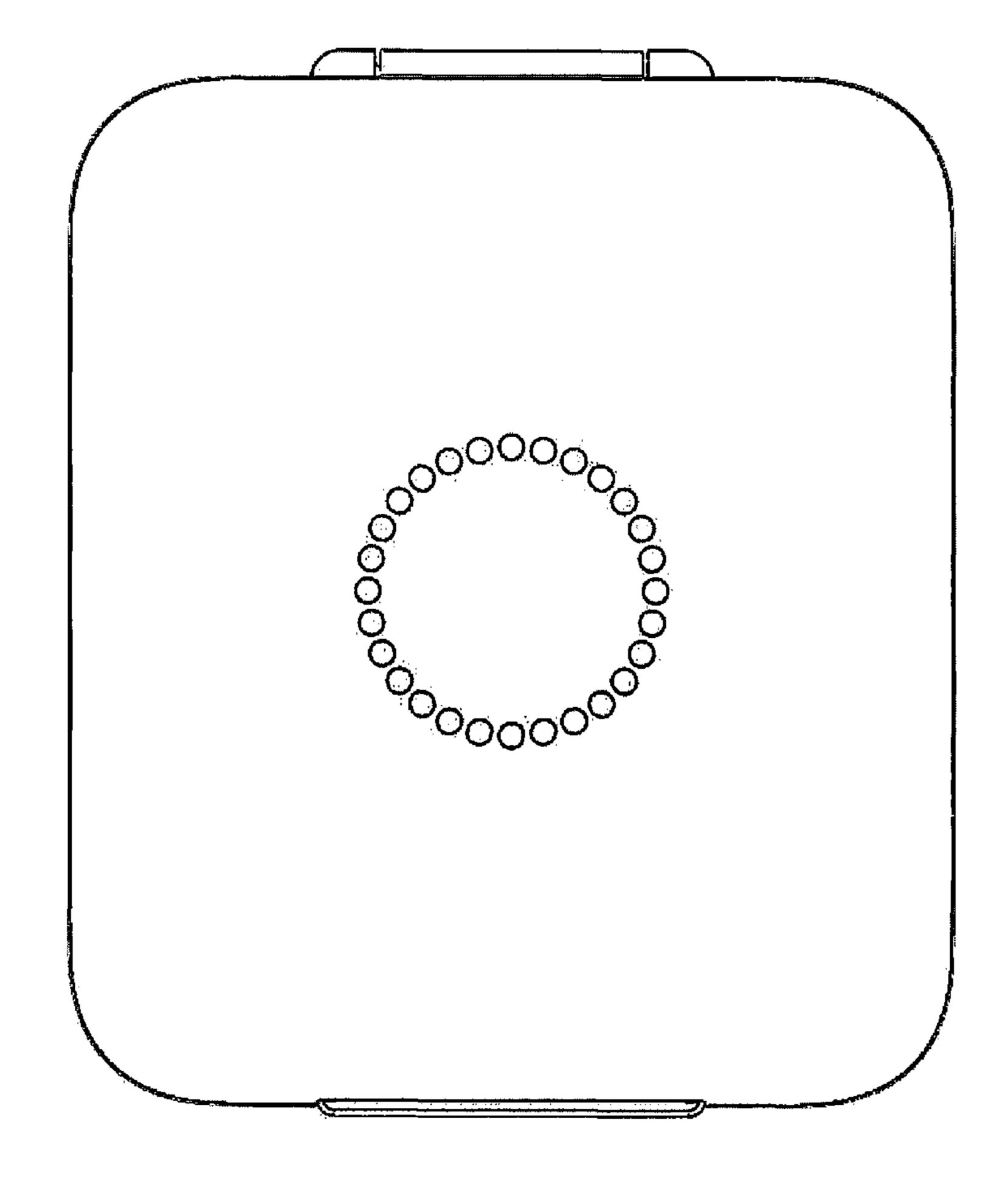


FIG. 5

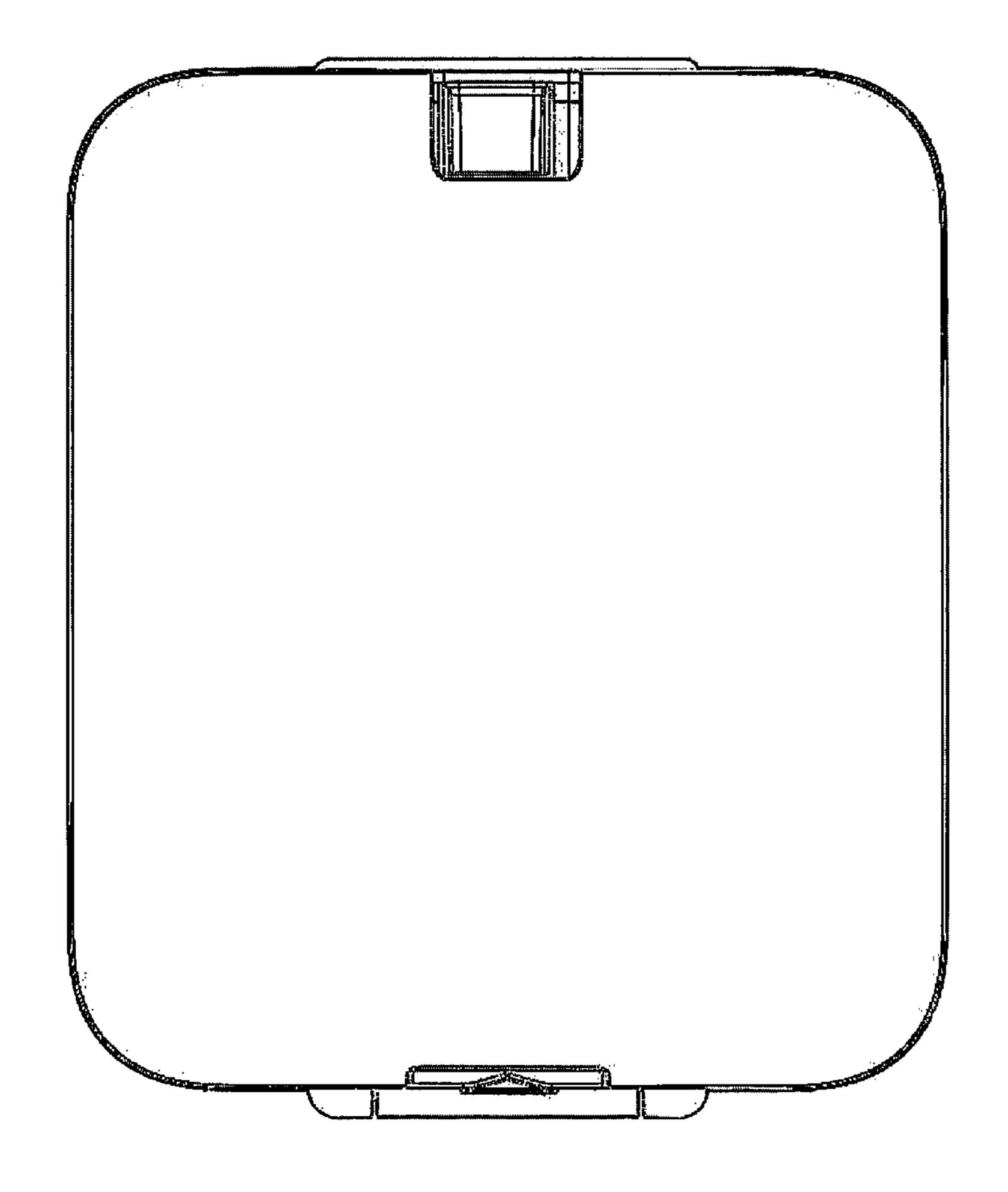
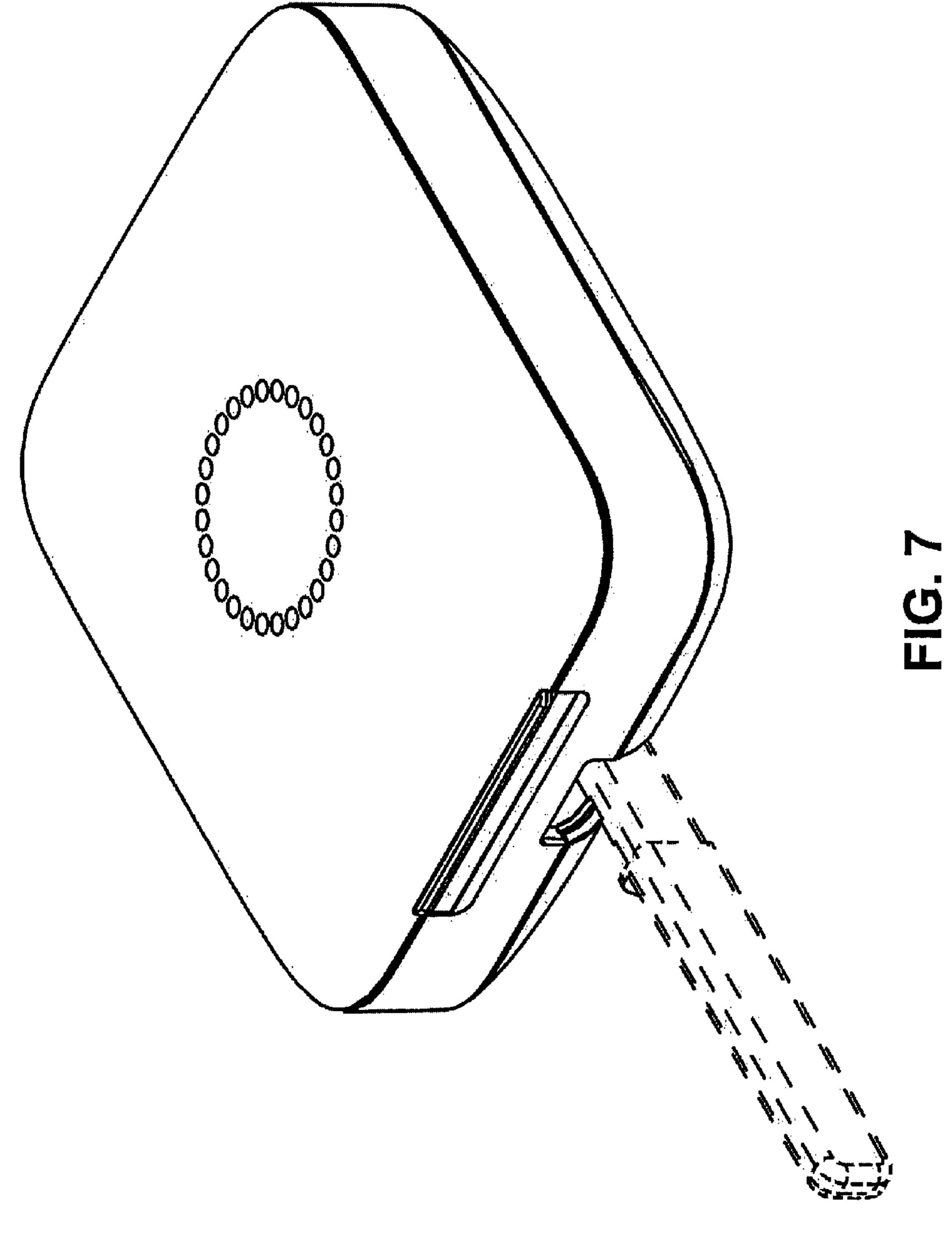
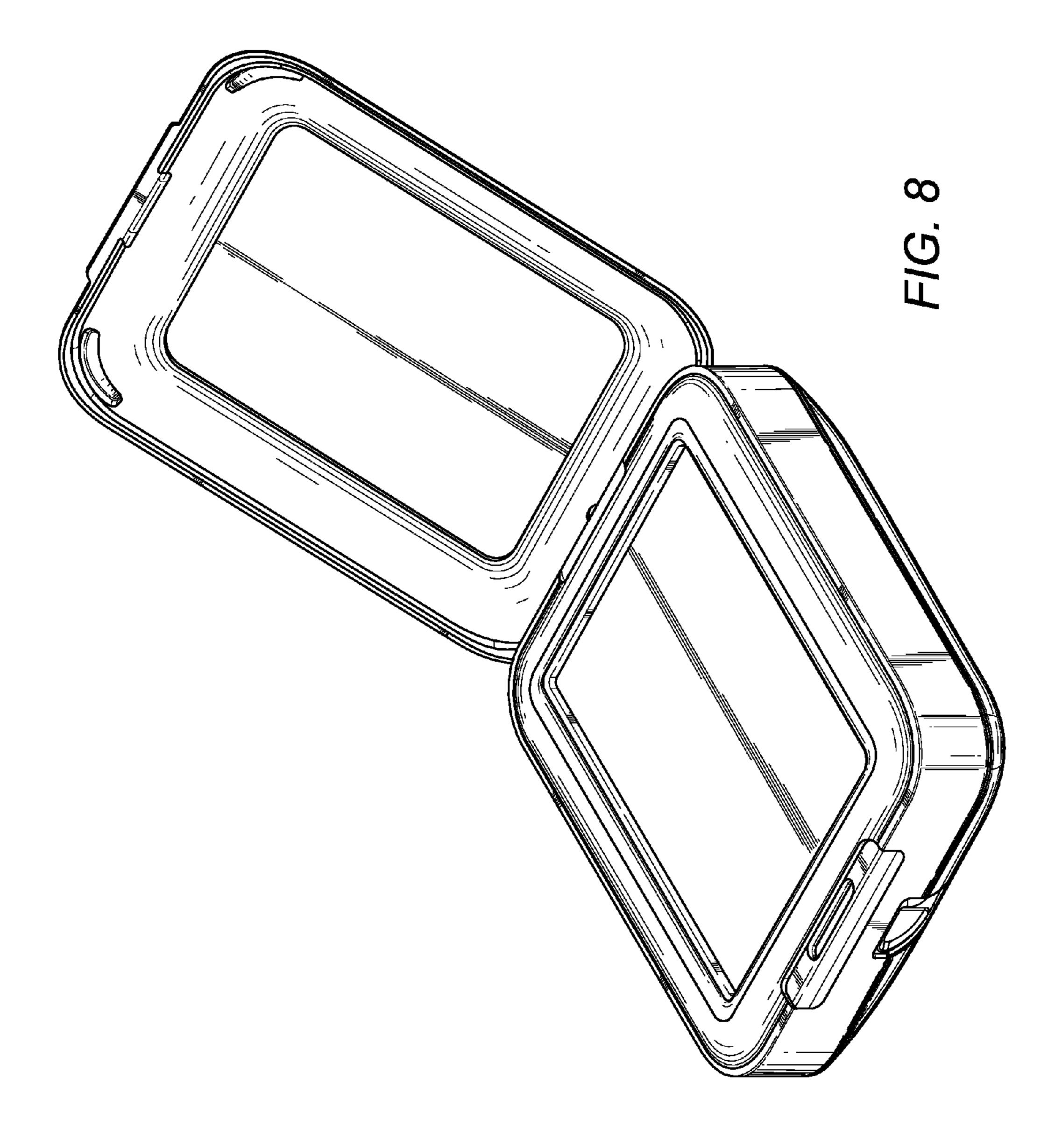


FIG. 6





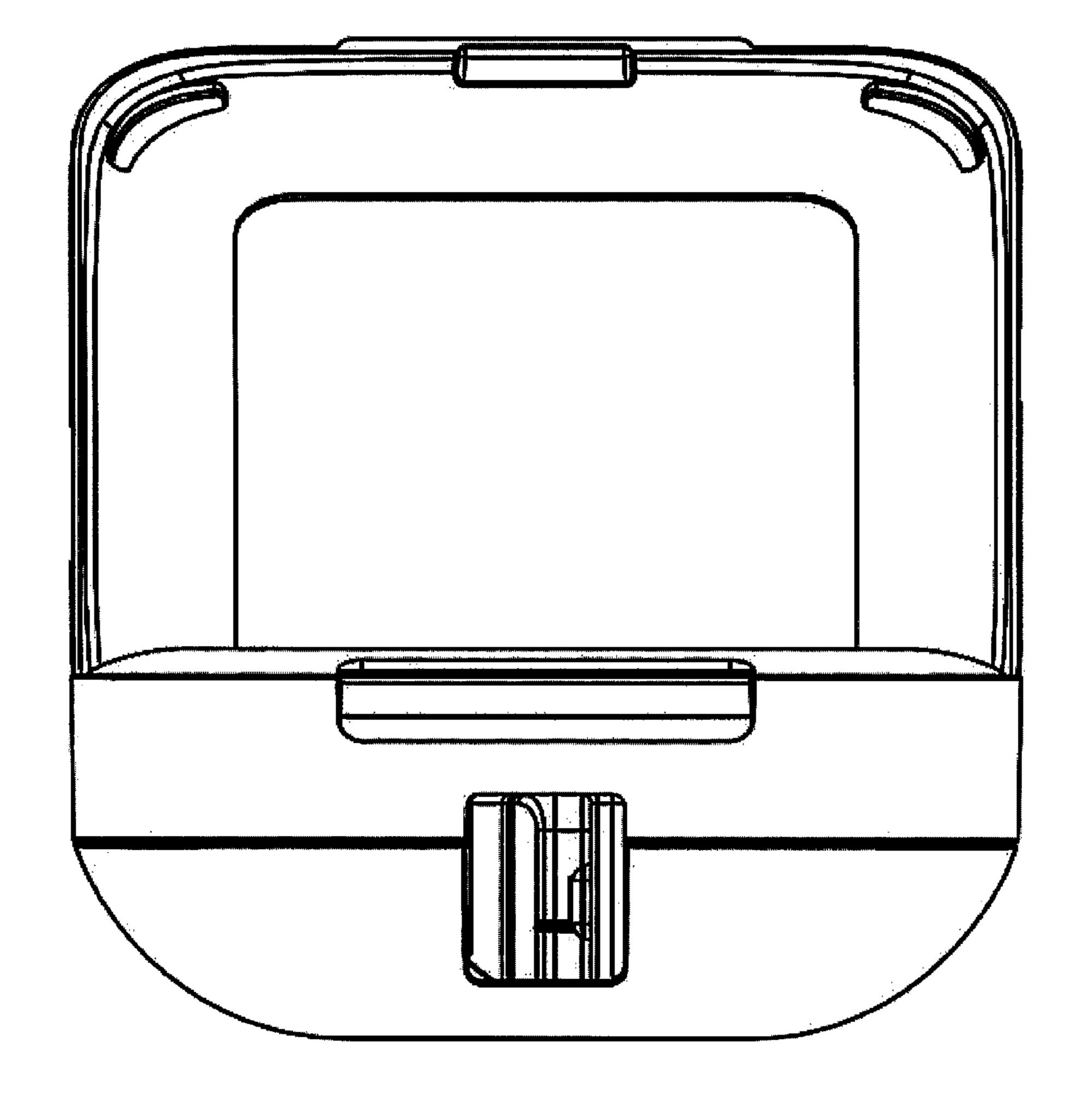
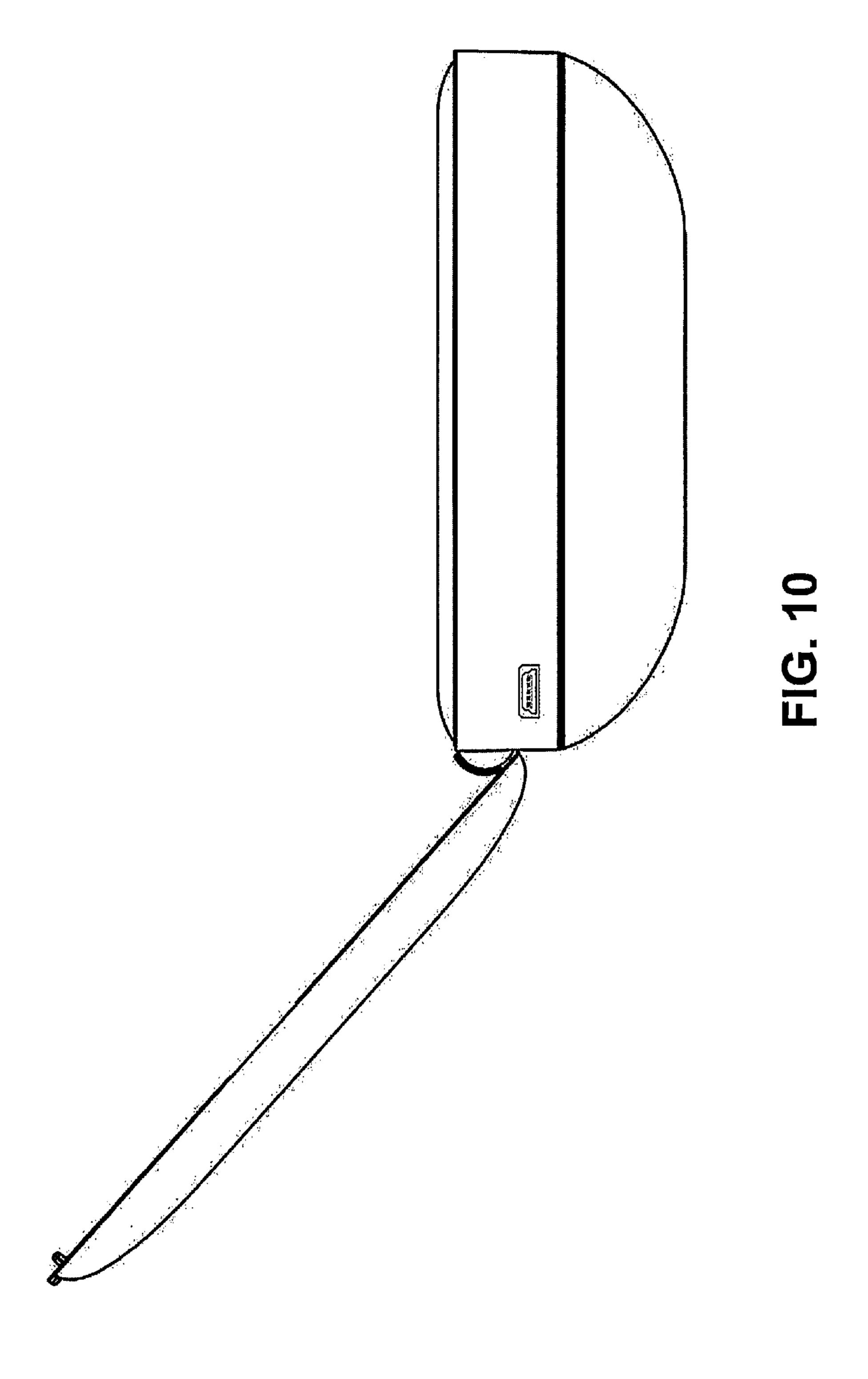


FIG. 9



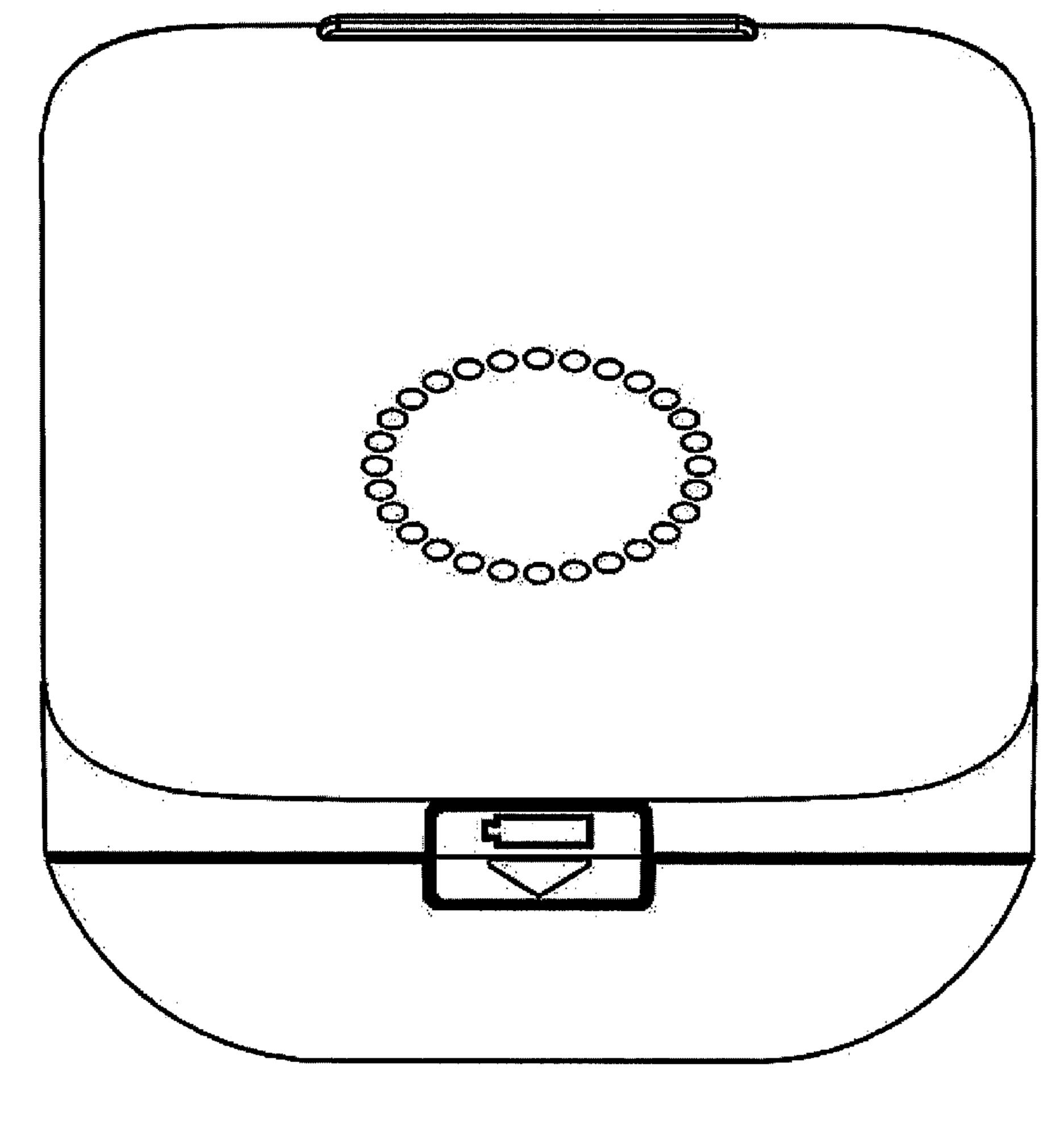


FIG. 11

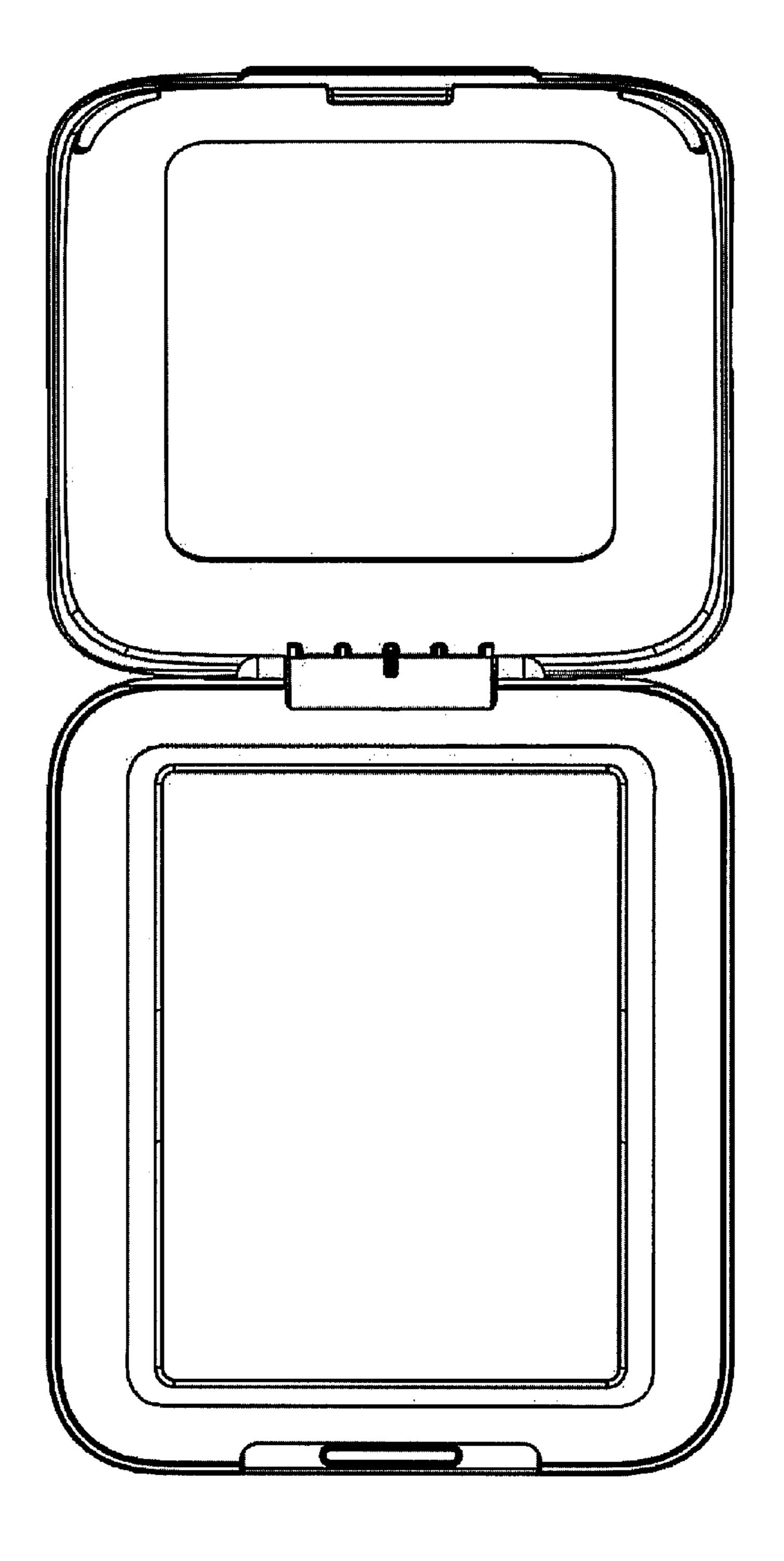
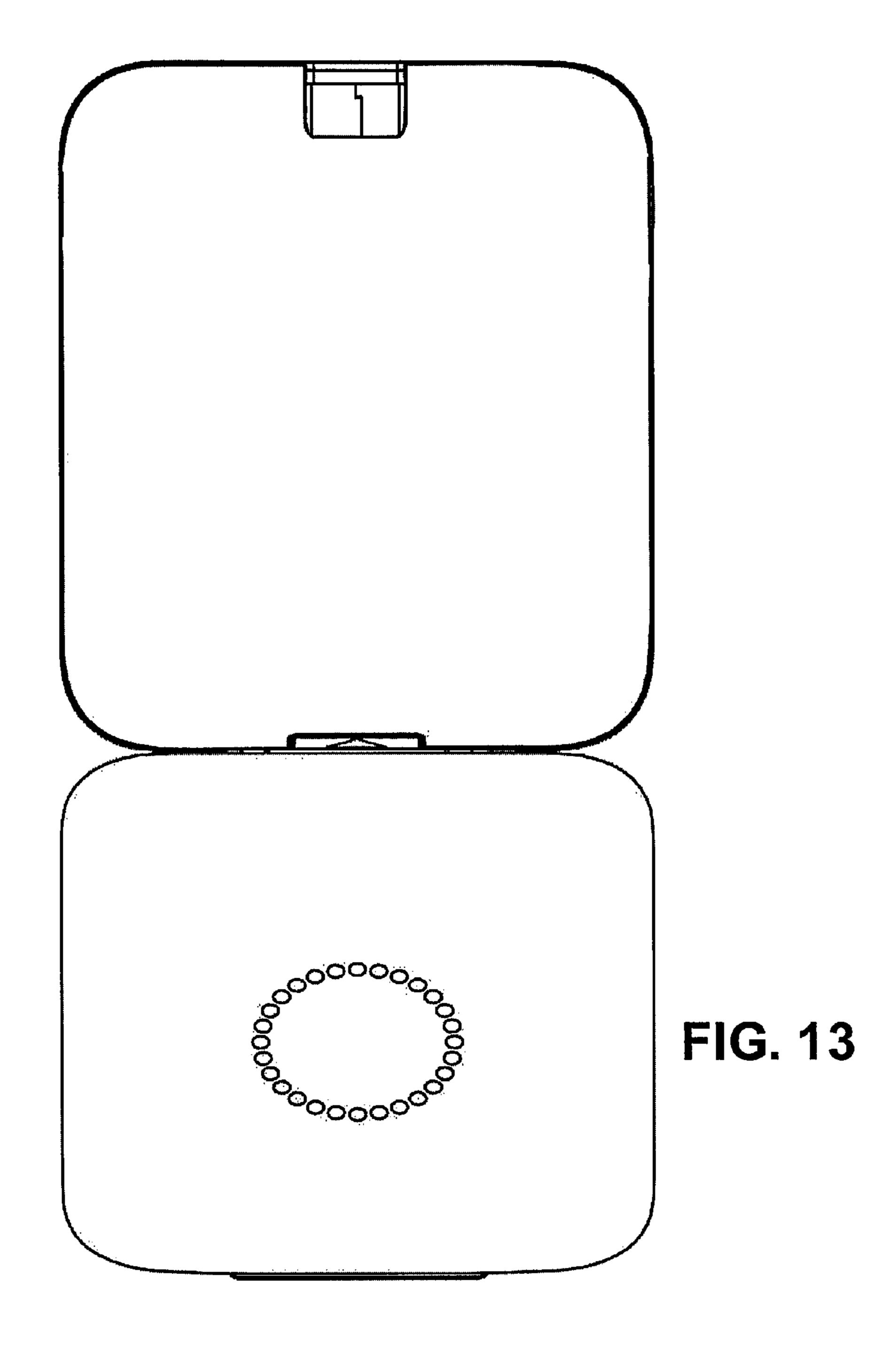
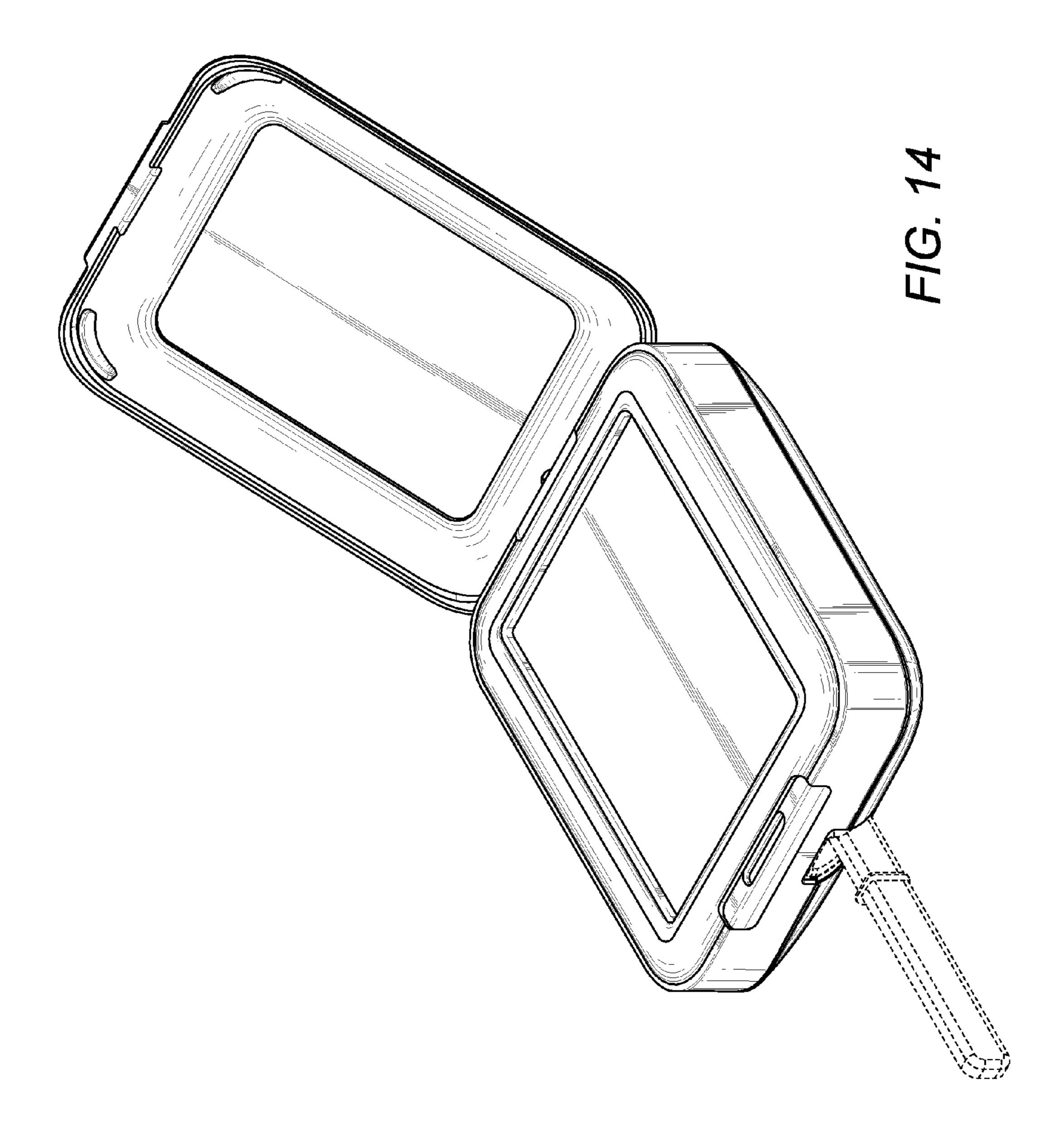


FIG. 12





UNITED STATES PATENT AND TRADEMARK OFFICE

CERTIFICATE OF CORRECTION

PATENT NO. : D675,336 S

APPLICATION NO. : 29/389578

DATED : January 29, 2013 INVENTOR(S) : Laverack et al.

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Please delete the title page and insert the title page showing an illustrative figure as attached.

In the Drawings

Please delete drawing sheets 1-14 and insert drawing sheets 1-14 with figures 1-14 as attached.

Signed and Sealed this Fourth Day of February, 2014

Michelle K. Lee

Michelle K. Lee

Deputy Director of the United States Patent and Trademark Office

(12) United States Design Patent

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TESTING APPARATUS (54)

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SPD Swiss Precision Diagnostics Assignee:

GmbH, Geneva (CH)

14 Years Term:

Appl. No.: 29/389,578

(22)Apr. 13, 2011 Filed:

(30)Foreign Application Priority Data

Oc	a. 13, 2010	(EM)	001767732-0007
Oc	a. 13, 2010	(EM)	001767732-0008
(51)	LOC (9) C	.,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	
(52)	U.S. Cl		
(58)	Field of Ch	assification Sea	rch D24/216-217.

D24/219, 222-226, 227, 231, 232, 107, 169, D24/186; D10/81; 422/400-404, 408, 430, 422/68.1, 69, 500; 435/287.1, 287.3, 287.4, 435/288.1, 288.3, 288.7, 806

See application file for complete search history.

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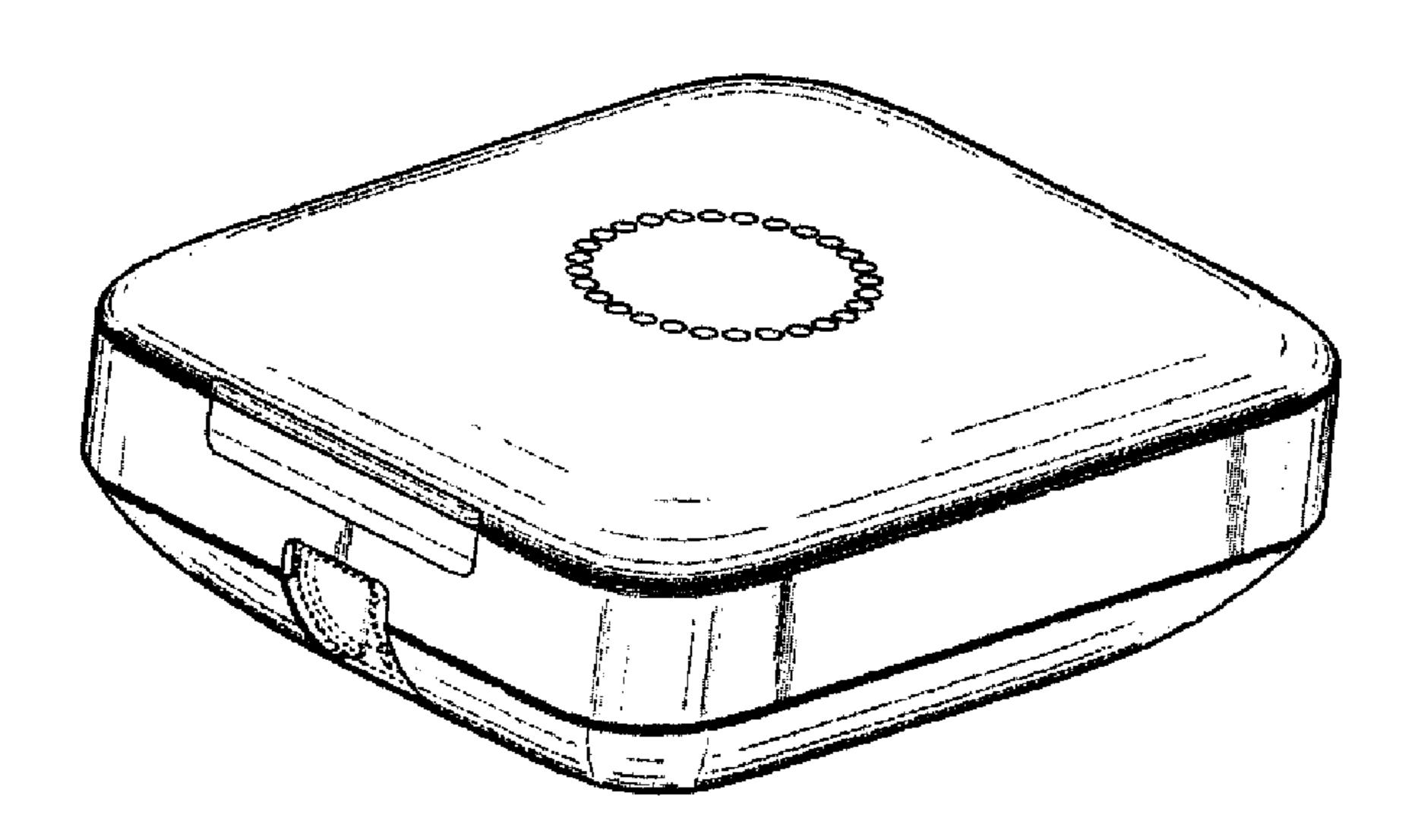
FIG. 12 is a top plan view of the testing apparatus in the openconfiguration;

FIG. 13 is a bottom plan view of the testing apparatus in the open configuration; and,

FIG. 14 is another perspective view of the testing apparatus in the open configuration, and further includes environmental structure illustrated in broken lines.

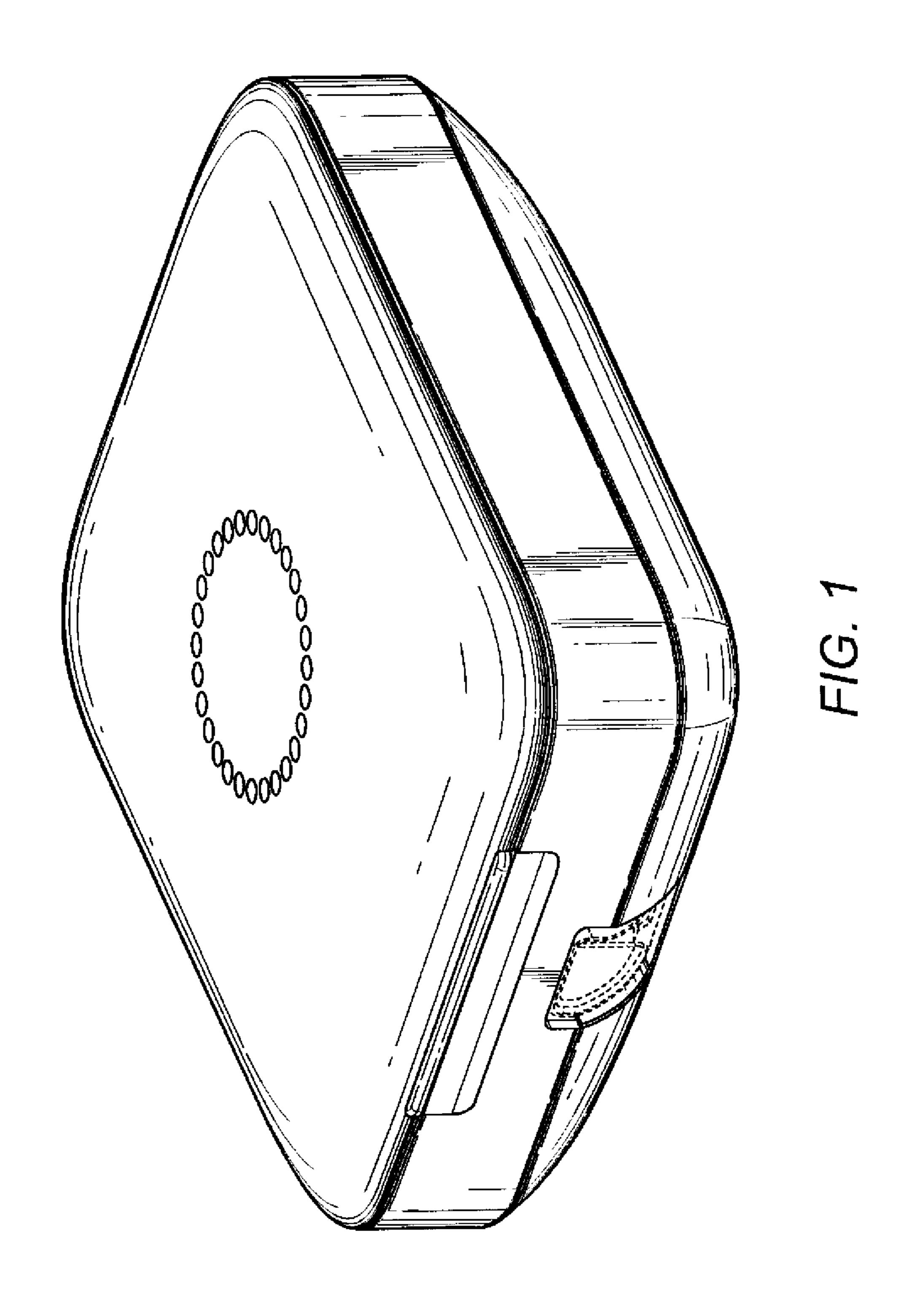
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1 Claim, 14 Drawing Sheets



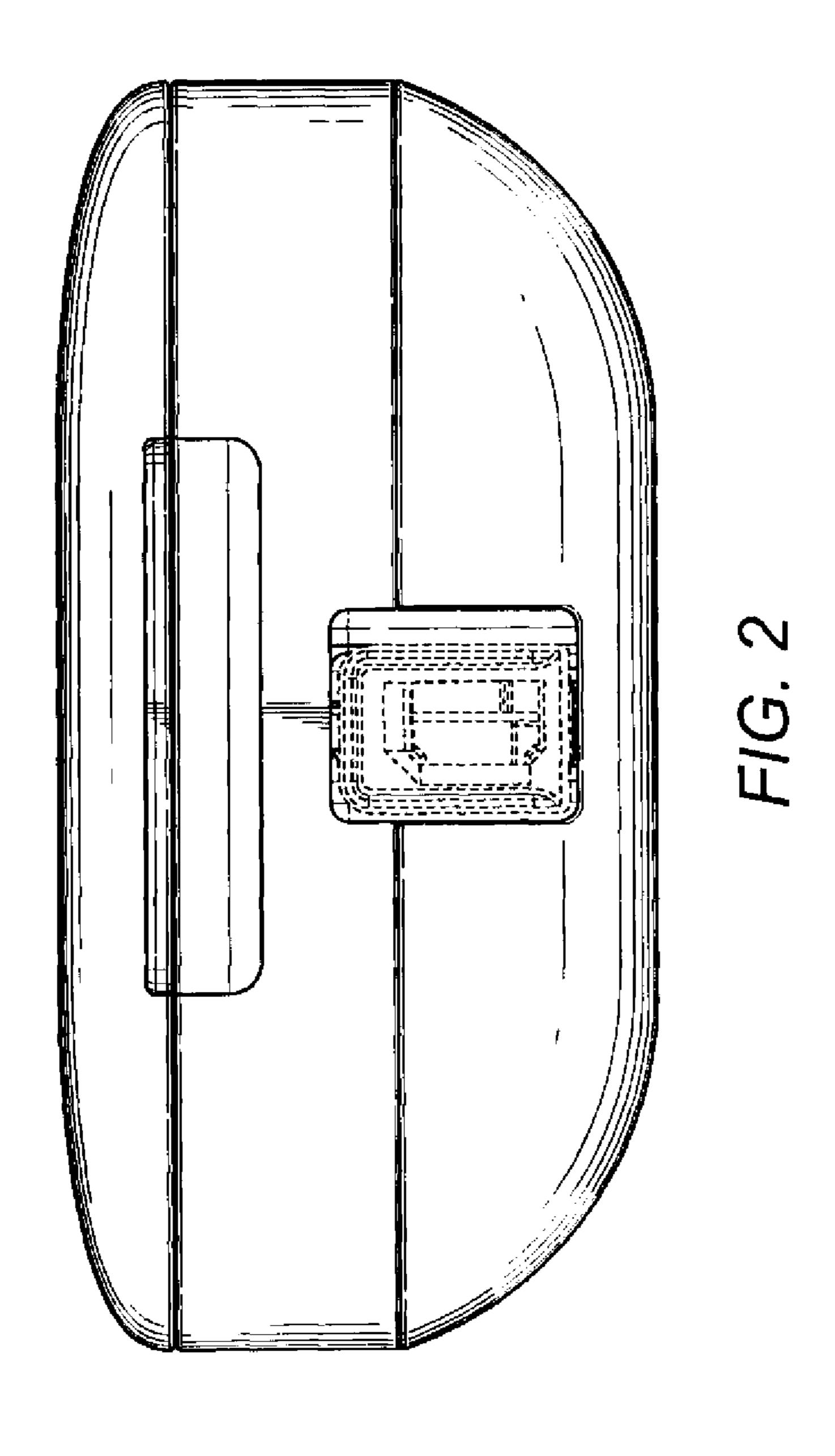
Jan. 29, 2013

Sheet 1 of 14



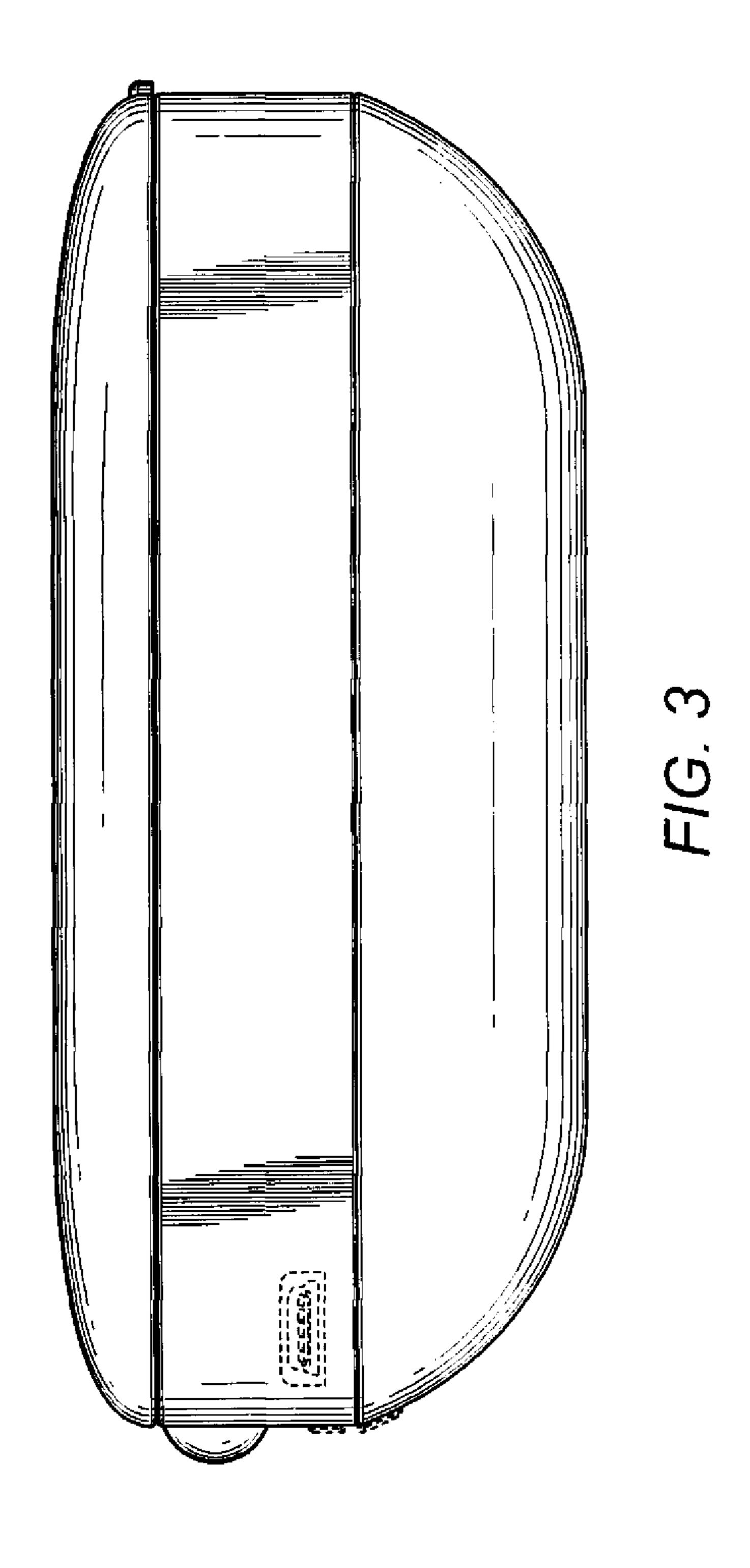
Jan. 29, 2013

Sheet 2 of 14



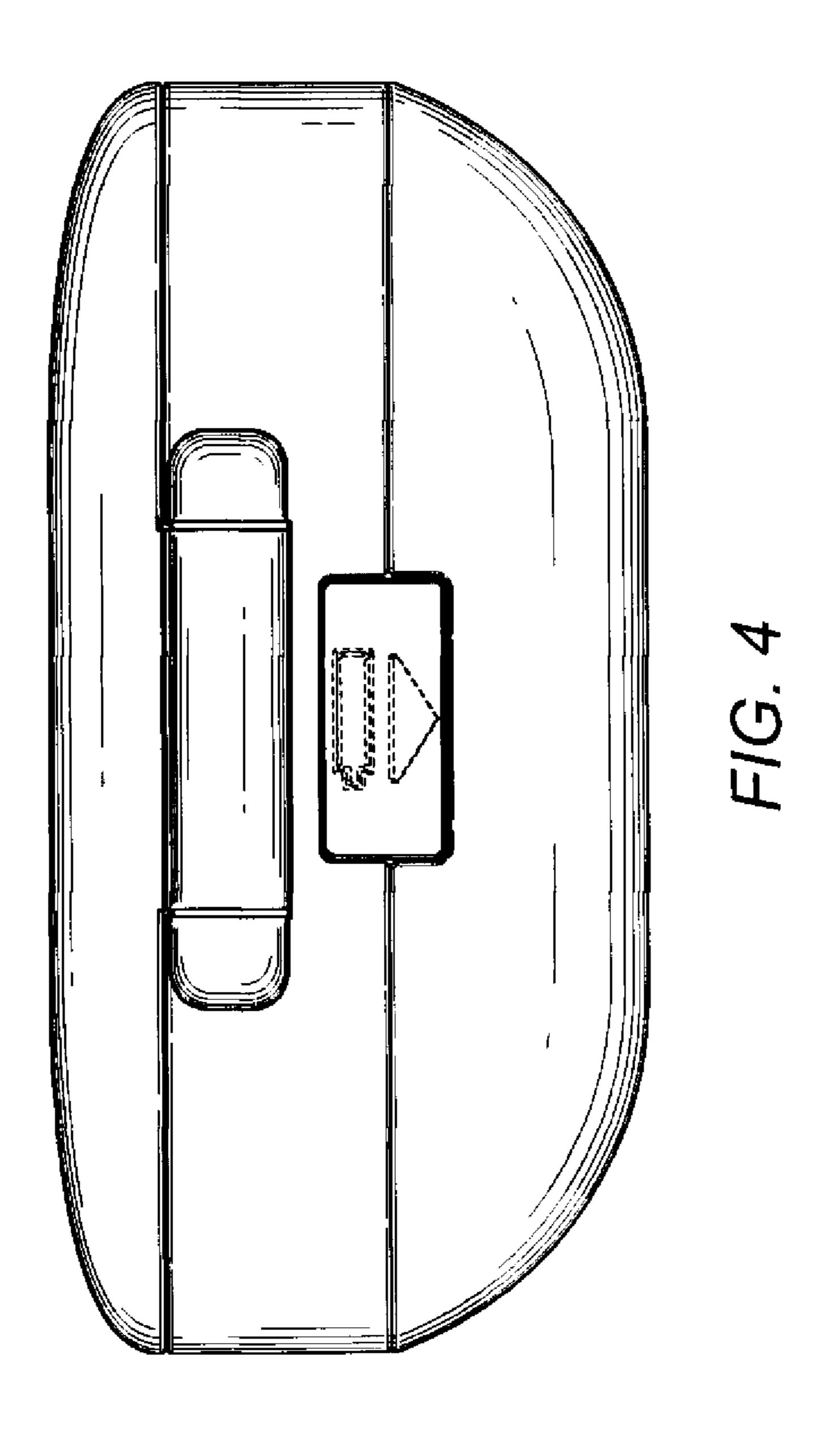
Jan. 29, 2013

Sheet 3 of 14



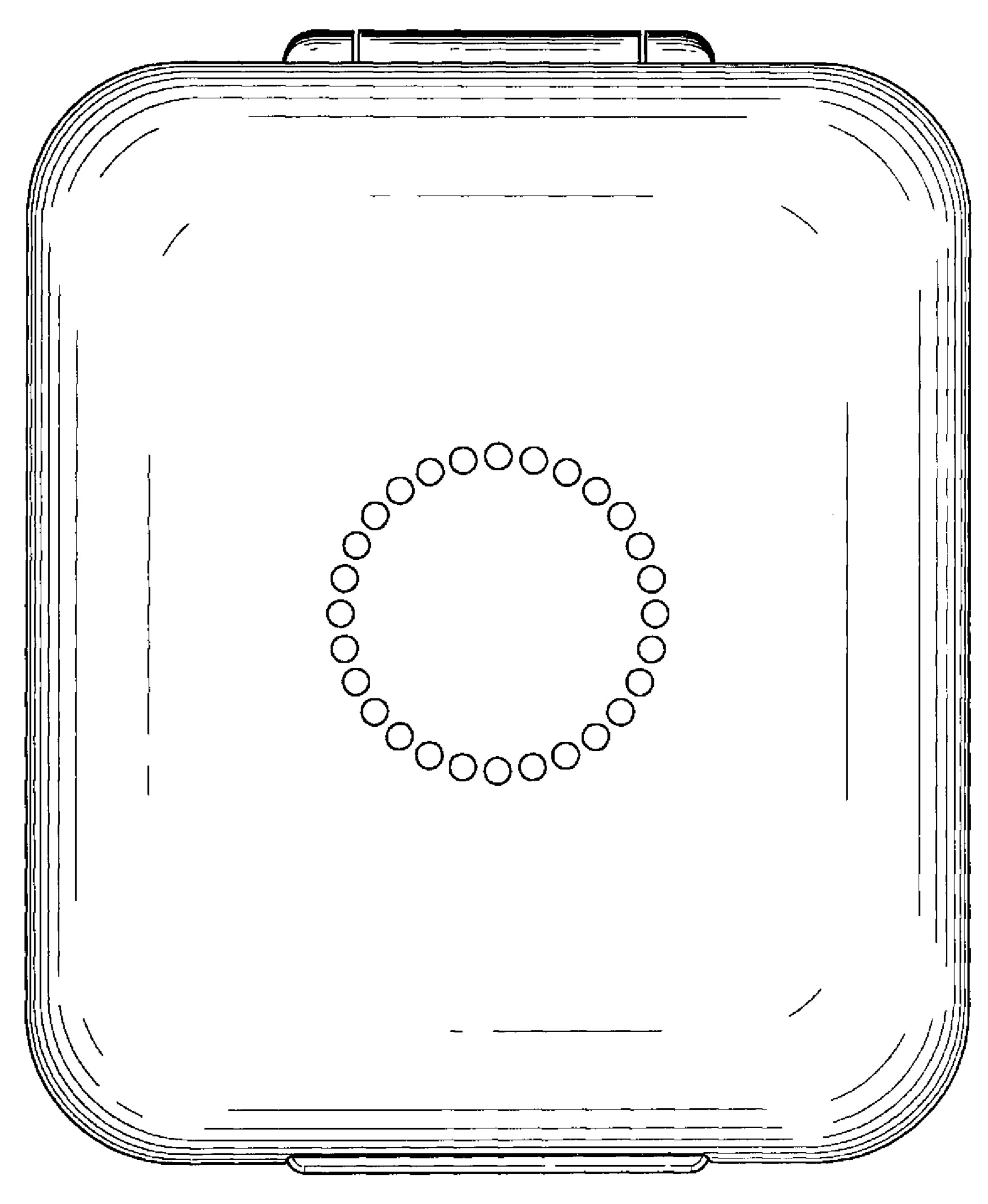
Jan. 29, 2013

Sheet 4 of 14



Jan. 29, 2013

Sheet 5 of 14



F/G. 5

Jan. 29, 2013

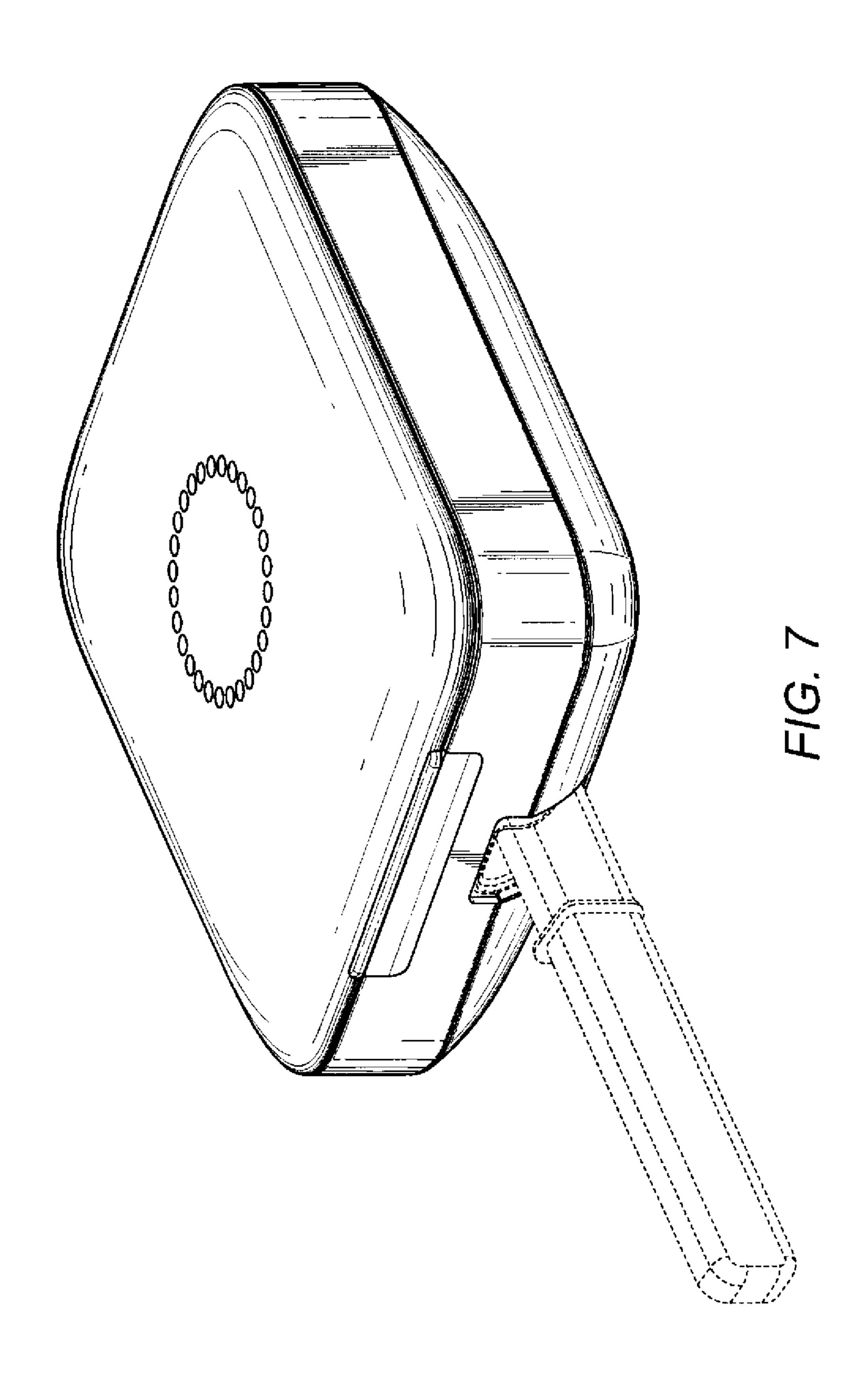
Sheet 6 of 14



F/G. 6

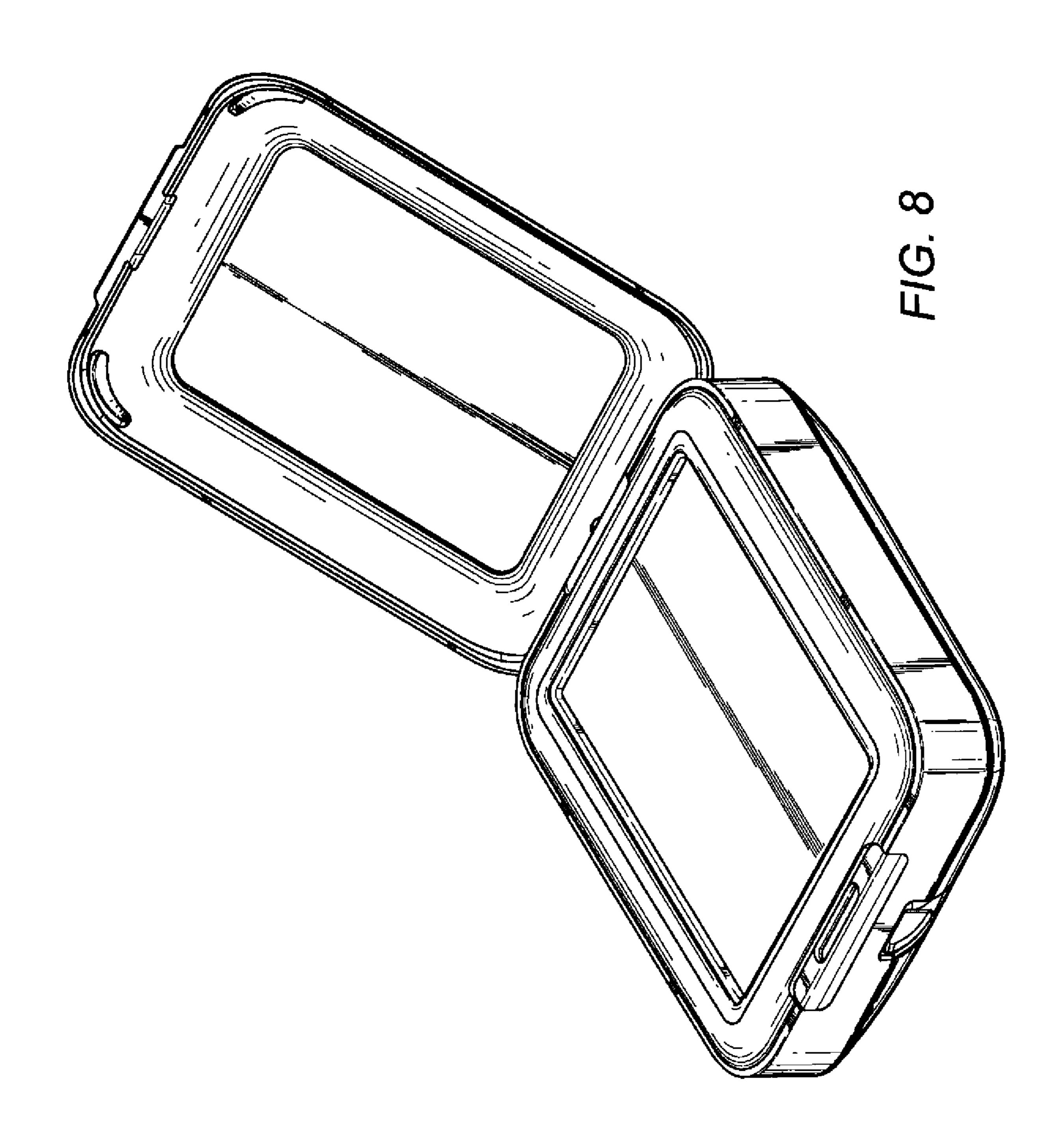
Jan. 29, 2013

Sheet 7 of 14



Jan. 29, 2013

Sheet 8 of 14



Jan. 29, 2013

Sheet 9 of 14

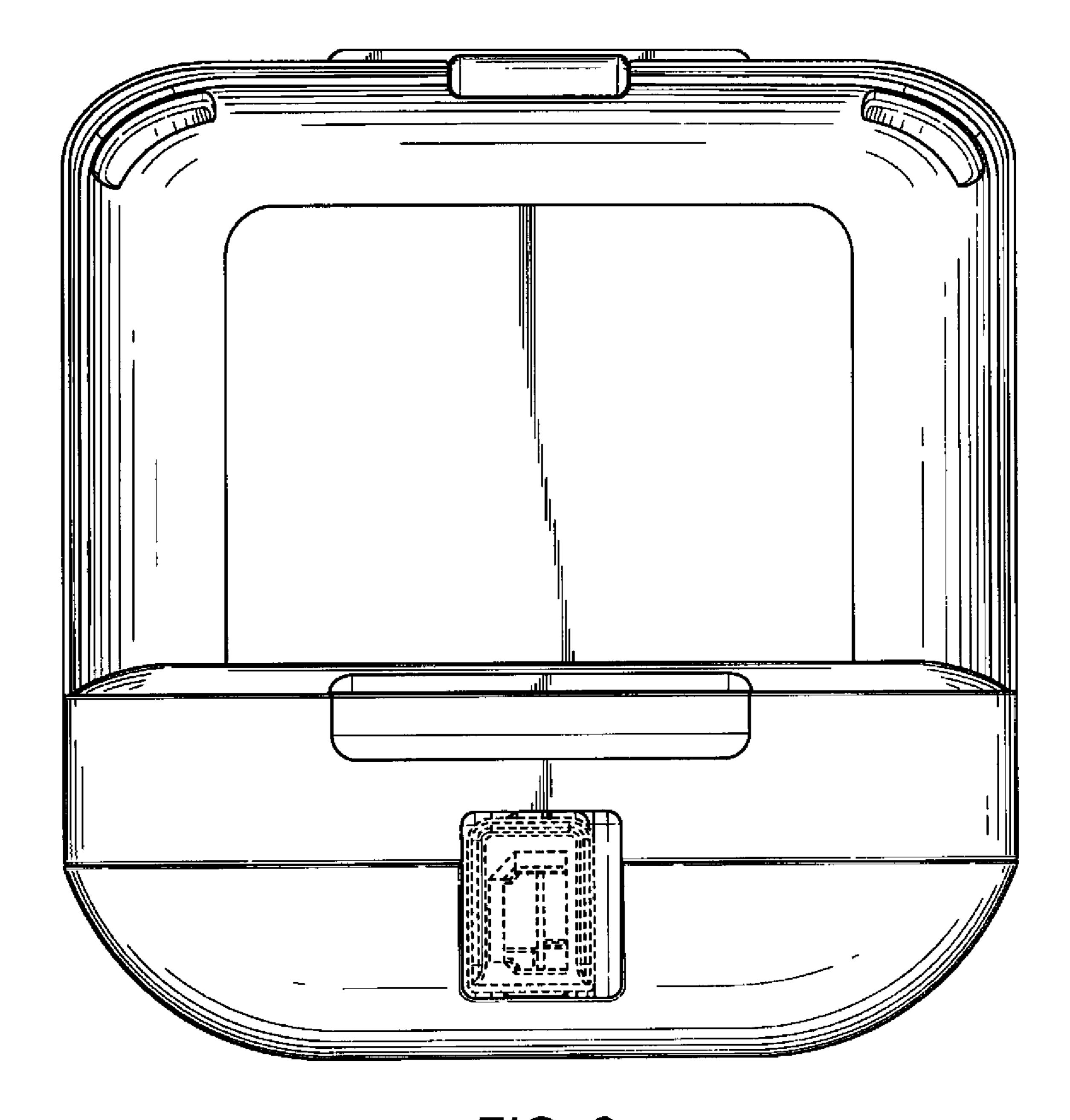
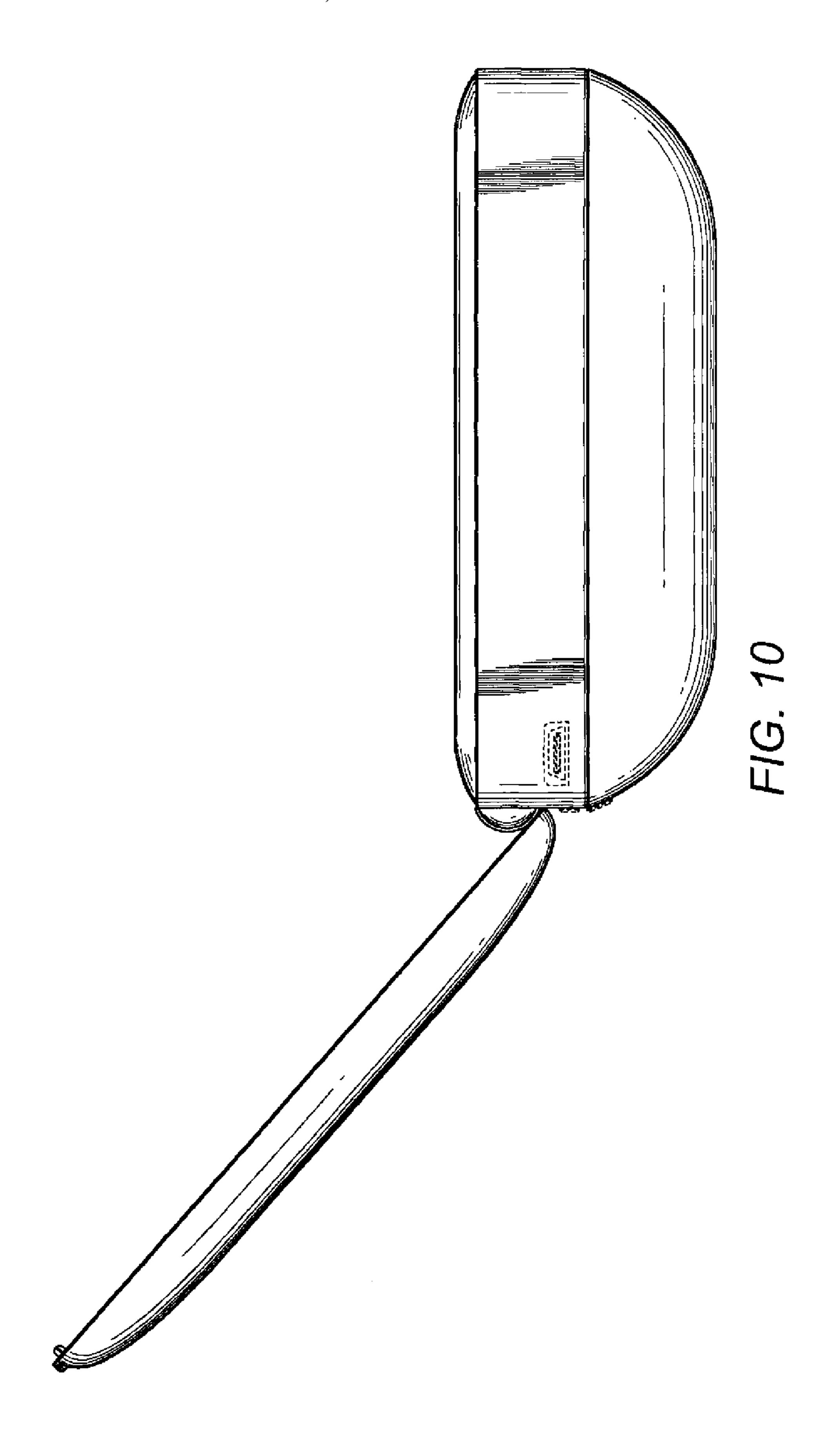


FIG. 9

Jan. 29, 2013

Sheet 10 of 14



Jan. 29, 2013

Sheet 11 of 14

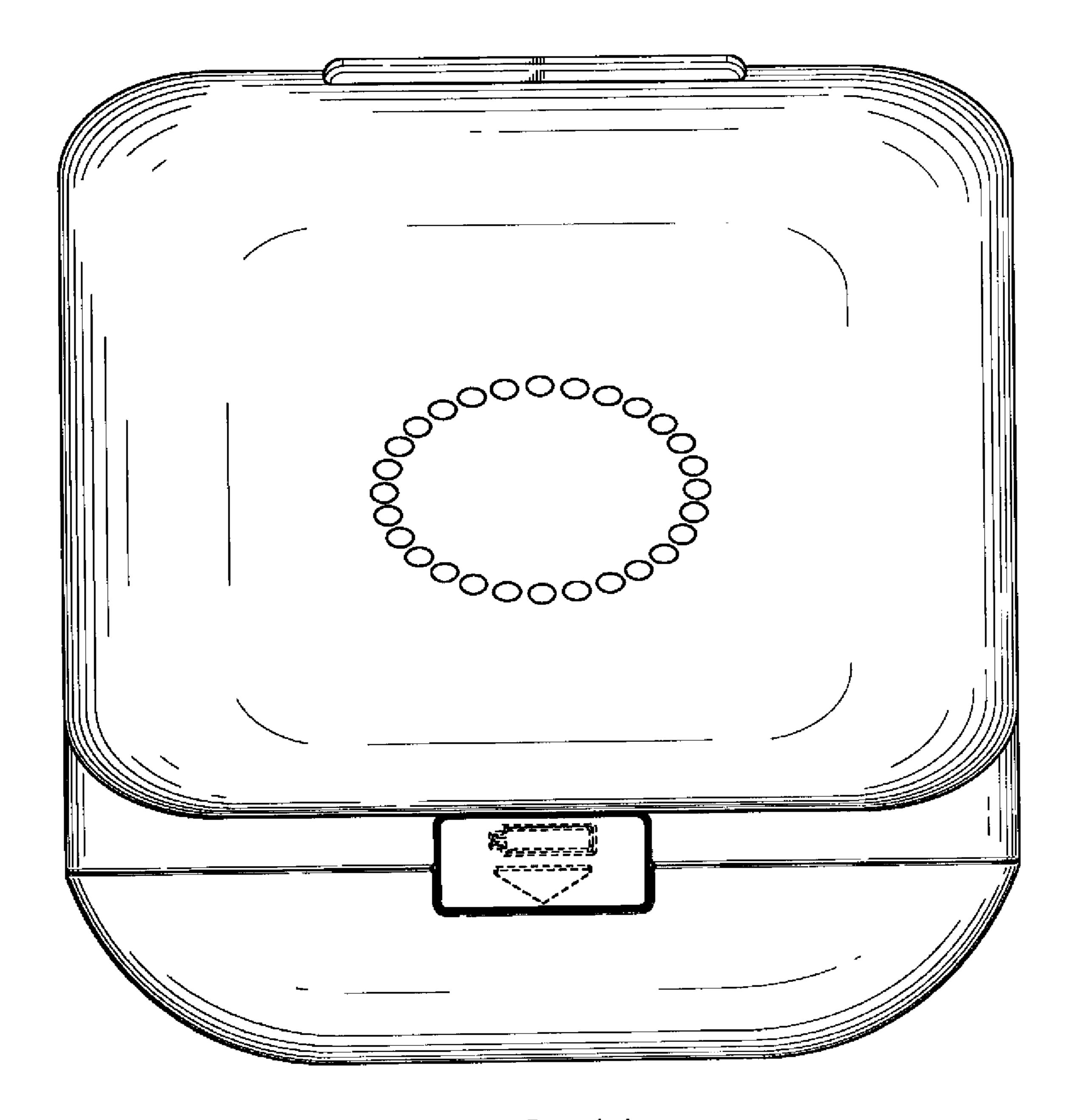
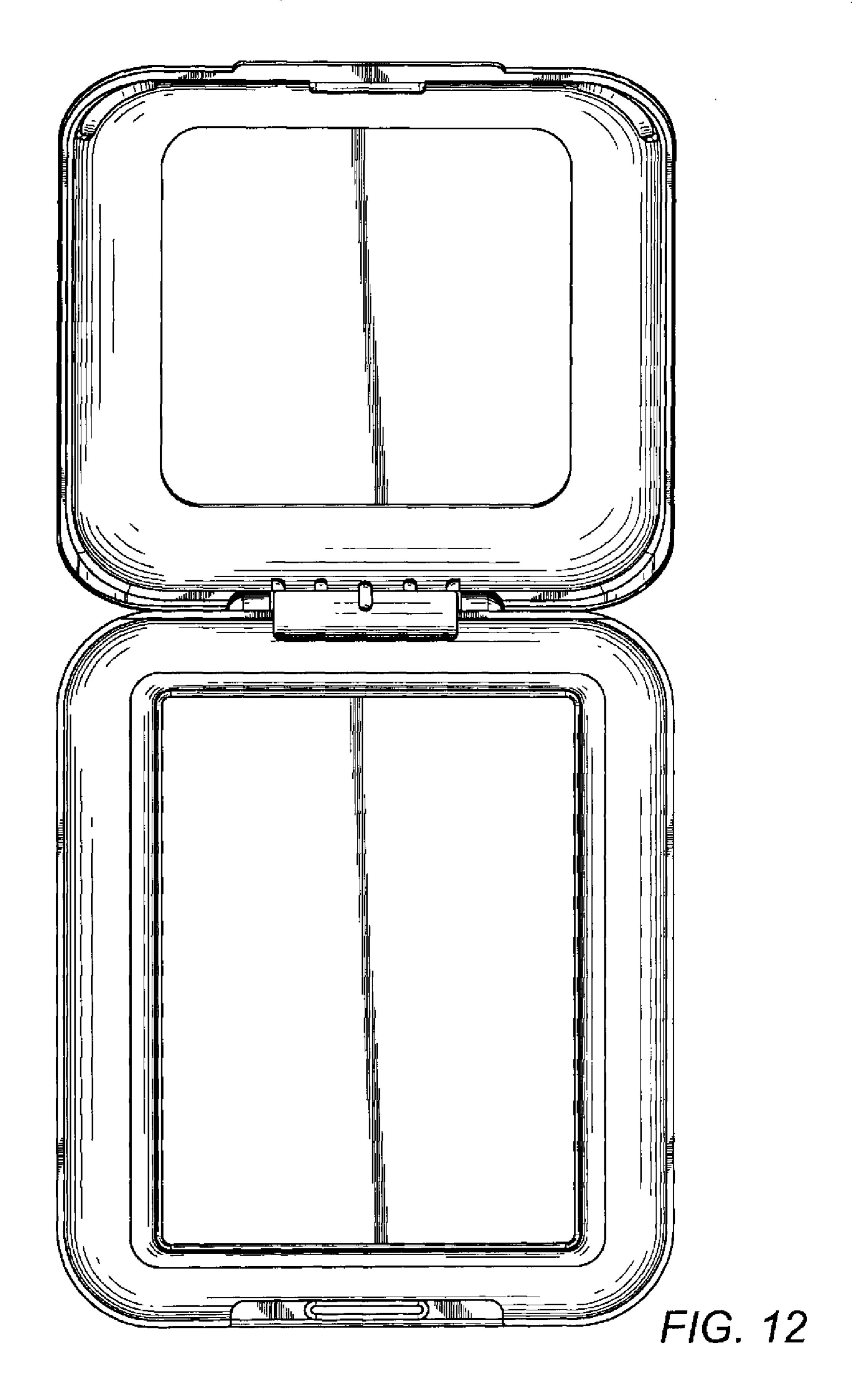


FIG. 11

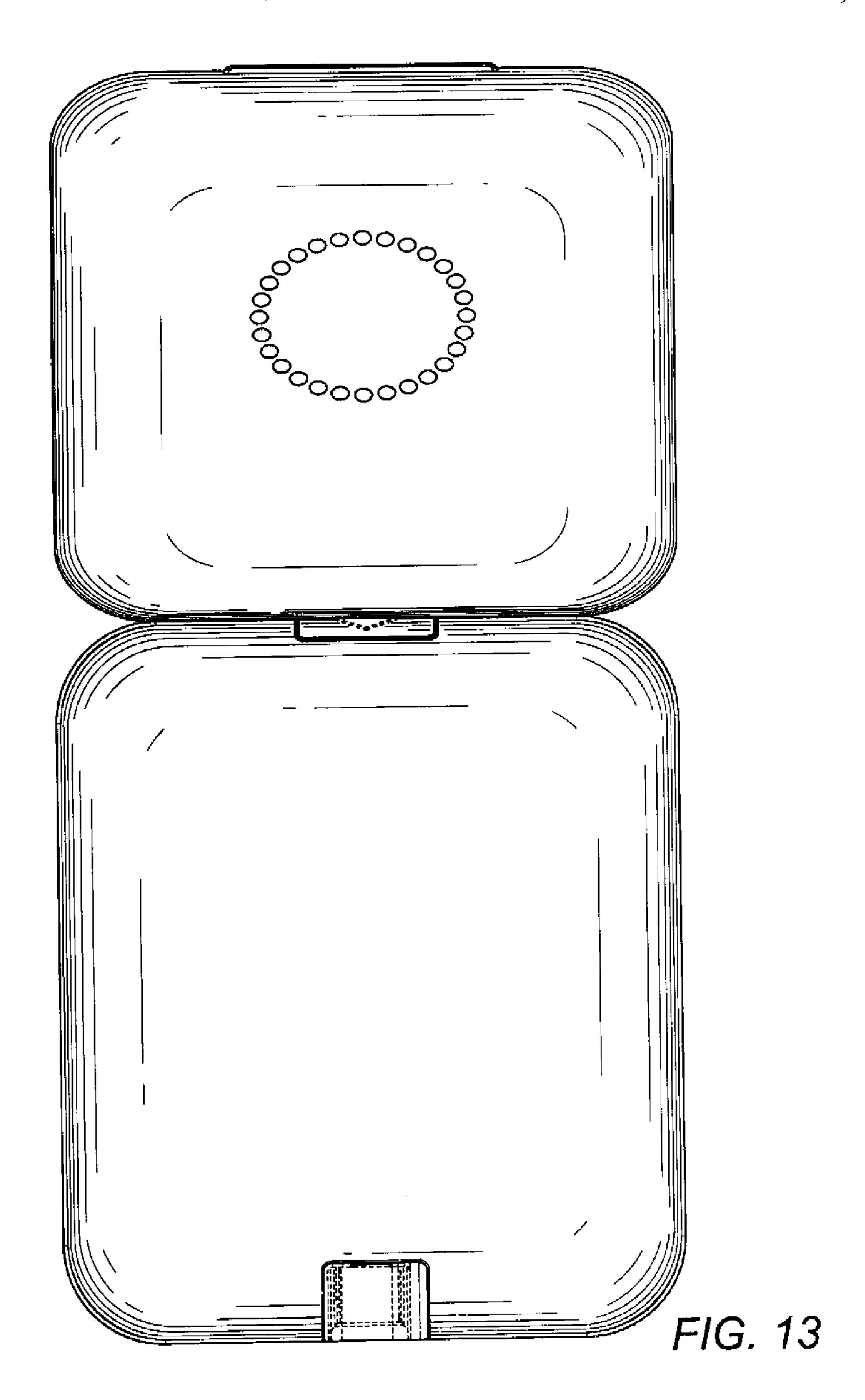
Jan. 29, 2013

Sheet 12 of 14



Jan. 29, 2013

Sheet 13 of 14



Jan. 29, 2013

Sheet 14 of 14

